

## **IGBT** Module

### SK60GAL125 SK60GAR125

**Target Data** 

#### **Features**

- · Compact design
- · One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- · High short circuit capability
- Ultra Fast NPT IGBT technology
- V<sub>ce,sat</sub> with positive coefficient

## **Typical Applications\***

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



Absolute Maximum Ratings T <sub>s</sub> = 25 °C, unless otherwise specifie							
Symbol	Conditions			Values	Units		
IGBT							
$V_{CES}$	T <sub>j</sub> = 25 °C			1200	V		
I <sub>C</sub>	T <sub>j</sub> = 125 °C	T <sub>s</sub> = 25 °C		51	Α		
		$T_s = 80  ^{\circ}C$		35	Α		
I <sub>CRM</sub>	I <sub>CRM</sub> = 2 x I <sub>Cnom</sub>			100	Α		
$V_{GES}$				± 20	V		
t <sub>psc</sub>	$V_{CC}$ = 300 V; $V_{GE} \le 20$ V; $V_{CES} < 600$ V	T <sub>j</sub> = 125 °C		10	μs		
Inverse Diode							
I <sub>F</sub>	T <sub>j</sub> = 150 °C	$T_s = 25 ^{\circ}C$		43	Α		
		$T_s = 80  ^{\circ}C$		29	Α		
I <sub>FRM</sub>	I <sub>FRM</sub> = 2 x I <sub>Fnom</sub>				Α		
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave	T <sub>j</sub> = 25 °C		110	Α		
Freewhee	eling Diode						
I <sub>F</sub>	T <sub>j</sub> = 150 °C	$T_s$ = 25 °C		57	Α		
		$T_s = 80  ^{\circ}C$		38	Α		
I <sub>FRM</sub>					Α		
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave	T <sub>j</sub> = 150 °C		550	Α		
Module							
$I_{t(RMS)}$					Α		
$T_{vj}$				-40 <b>+</b> 150	°C		
T <sub>stg</sub>				-40 <b>+</b> 125	°C		
V <sub>isol</sub>	AC, 1 min.			2500	V		

Characteristics		$T_s =$	= 25 °C, unless otherwise specified				
Symbol	Conditions		min.	typ.	max.	Units	
IGBT	•						
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 2 \text{ mA}$		4,5	5,5	6,5	V	
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = V_{CES}$	T <sub>j</sub> = 25 °C			0,006	mA	
$I_{\text{GES}}$	$V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}$	T <sub>j</sub> = 25 °C			300	nA	
$V_{CE0}$		T <sub>j</sub> = 25 °C		1,4	1,9	V	
		T <sub>j</sub> = 125 °C		1,7	2,2	V	
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C		36		mΩ	
		$T_j = 125^{\circ}C$		43		mΩ	
V <sub>CE(sat)</sub>	I <sub>Cnom</sub> = 50 A, V <sub>GE</sub> = 15 V			3,2	3,7	V	
		$T_j = 125^{\circ}C_{chiplev.}$		3,85		V	
C <sub>ies</sub>				3,3		nF	
C <sub>oes</sub>	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,5		nF	
C <sub>res</sub>				0,22		nF	
t <sub>d(on)</sub>						ns	
ţ,	$R_{Gon} = 33 \Omega$	V <sub>CC</sub> = 600V				ns	
E <sub>on</sub>	D 00 0	I <sub>C</sub> = 45A		8,36		mJ	
t <sub>d(off)</sub>	$R_{Goff} = 33 \Omega$	$T_j = 125 ^{\circ}\text{C}$				ns	
t <sub>f</sub>		V <sub>GE</sub> =±15V				ns	
E <sub>off</sub>				3,32		mJ	
$R_{th(j-s)}$	per IGBT				0,6	K/W	

## **SK60GAL125**



SEMITOP® 2

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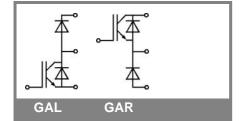
### **Typical Applications\***

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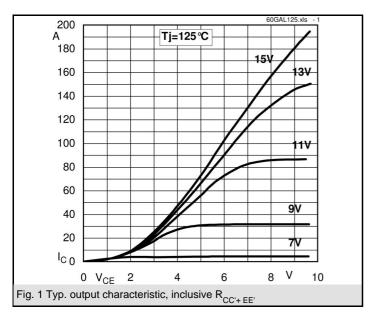
Characteristics								
Symbol	Conditions	İ	min.	typ.	max.	Units		
Inverse Diode								
$V_F = V_{EC}$	$I_{Fnom} = 10 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25  ^{\circ}C_{\text{chiplev.}}$		2	2,5	V		
		$T_j = 150  ^{\circ}C_{\text{chiplev.}}$		1,79	2,3	V		
$V_{F0}$		T <sub>j</sub> = 25 °C				V		
		T <sub>j</sub> = 125 °C		1,18		V		
r <sub>F</sub>		T <sub>j</sub> = 25 °C				mΩ		
		T <sub>j</sub> = 125 °C		31,5		mΩ		
I <sub>RRM</sub>	I <sub>F</sub> = 30 A	T <sub>j</sub> = 125 °C				Α		
$Q_{rr}$	di/dt = -100 A/μs					μC		
E <sub>rr</sub>	V <sub>CC</sub> = 400V					mJ		
$R_{th(j-s)D}$	per diode				1,16	K/W		
	Freewheeling Diode							
$V_F = V_{EC}$	$I_{Fnom}$ = 50 A; $V_{GE}$ = 0 V	$T_j = 25  ^{\circ}C_{chiplev.}$		2	2,5	V		
		$T_j = 125  ^{\circ}C_{\text{chiplev.}}$		1,8		V		
V <sub>F0</sub>		T <sub>j</sub> = 125 °C		1	1,2	V		
r <sub>F</sub>		T <sub>j</sub> = 125 °C		16	22	V		
I <sub>RRM</sub>	I <sub>F</sub> = 50 A	T <sub>j</sub> = 125 °C				Α		
$Q_{rr}$	di/dt = -800 A/µs					μC		
E <sub>rr</sub>	V <sub>R</sub> =600V					mJ		
$R_{\text{th(j-s)FD}}$	per diode				0,9	K/W		
M <sub>s</sub>	to heat sink				2	Nm		
w				19		g		

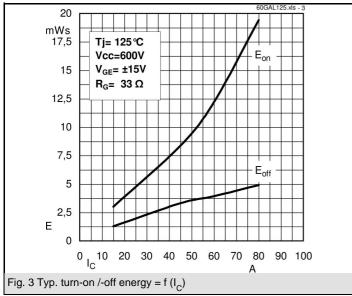
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

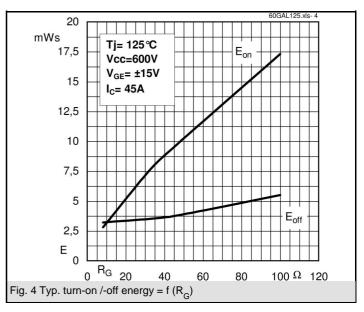
\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.

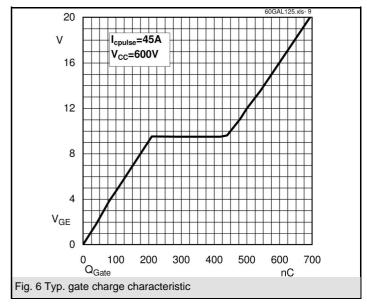


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